FORM PTO-1449 U.S. DEPARTMENT OF COMMERCI (REV. 7:80) PATENT AND TRADEMARK OFFICE										ATTY. DOCKET NO.: SERIAL NO.: 10/701 200.1133CON2			01,041		
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*EXAMINER	3 20/							U.	S. PATENT DOC	CUMENTS					
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	AA	6	0	0	4	9	7	0	12/21/99	O'Malley et al.			<u></u>		
	AB	6	5	5	2	0	3	1	04/22/03	Burch et al.					
	AC	7	1	4	4	5	8	7	12/05/06	Oshlack et al.				·	
	AD	7	1	7	2	7	6	7	02/06/07	Kaiko et al.				٠	
	AE	7	3	3	2	1	8	2	02/19/08	Sackler					
	AF 6 7 6 5 0 1 0					0	07/20/04	Crain et al.							
	AG	6	1	2	0	8	0	6	09/19/00	Whitmire					
	АН	5	4	1	1	9	6	5	05/02/95	Reid et al.					
	Al	20	02	00	58	6	7	3	05/16/02	Kaiko et al.					
	AJ	20	03	01	91	1	4	7	10/09/03	Sherman et al.					
	AK	20	04	01	86	1	2	1	09/23/04	Oshlack et al.					
	AL	20	03	00	68	3	7	1	04/10/03	Oshlack et al.					
	АМ	20	03	01	57	1	6	8	08/21/03	Breder et al.					
	AN	20	03	00	69	2	6	3	11/18/03	Oshlack et al.					
	AO	20	04	01	92	7	1	5	09/30/04	Chasin et al.					
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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (REV. 7280) PATENT AND TRADEMARK OFFICE										ATTY. DOCKET NO.: SERIAL NO. 200.1133CON2			10/701,041		
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	BA	20	05	02	45	4	8	3	11/03/05	Brogmann et al.					
	BB	20	05	02	45	5	5	6	11/03/05	Brogmann et al.					
	вс	20	05	02	45	5	5	7	11/03/05	Schoenhard et al.					
	BD	20	04	02	28	9	2	4	11/18/04	Oshlack et al.					
	BE	20	06	01	82	8	0	1	08/17/06	Breder et al.					
	BF	20	07	00	14	7	3	2	01/18/07	Sackler					
	BG	20	07	01	22	3	4	8	05/31/07	Kaiko et al.					
	ВН	20	07	00	14	7	3	2	01/18/07	Sackler					
	81	20	08	00	20	0	2	8	01/24/08	Shevchuk et al.					
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